IAPO8Rec'd PCT 26 NOV 2008

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Isao YOKOKAWA

Group Art Unit: 2812

Application No.: 10/584,771

Examiner: C. LEE

Filed: June 28, 2006

Docket No.: 128503

For: METHOD FOR MEASURING AN AMOUNT OF STRAIN OF A BONDED

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AMENDMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In response to the November 14, 2008, Office Action issued under Ex parte Quayle, please consider the following:

Amendments to the Specification;

Amendments to the Claims as reflected in the listing of claims; and

Remarks.